

SCES3620A – DECEMBER 2004–REVISED FEBRUARY 2010

8-BIT UNIVERSAL BUS TRANSCEIVER AND TWO 1-BIT BUS TRANSCEIVERS WITH SPLIT LVTTL PORT, FEEDBACK PATH, AND 3-STATE OUTPUTS

Check for Samples: SN74VMEH22501A

FEATURES

- Member of the Texas Instruments Widebus™ Family
- UBT[™] Transceiver Combines D-Type Latches and D-Type Flip-Flops for Operation in Transparent, Latched, or Clocked Modes
- OEC[™] Circuitry Improves Signal Integrity and Reduces Electromagnetic Interference (EMI)
- Compliant With VME64, 2eVME, and 2eSST Protocols
- Bus Transceiver Split LVTTL Port Provides a Feedback Path for Control and Diagnostics Monitoring
- I/O Interfaces Are 5-V Tolerant
- B-Port Outputs (-48 mA/64 mA)
- Y and A-Port Outputs (-12 mA/12 mA)
- I_{off}, Power-Up 3-State, and BIAS V_{CC} Support Live Insertion
- Bus Hold on 3A-Port Data Inputs
- 26-Ω Equivalent Series Resistor on 3A Ports and Y Outputs
- Flow-Through Architecture Facilitates Printed Circuit Board Layout
- Distributed V_{CC} and GND Pins Minimize High-Speed Switching Noise
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II

- ESD Protection Exceeds JESD 22
 - 2000-V Human-Body Model (A114-A)
 - 200-V Machine Model (A115-A)
 - 1000-V Charged-Device Model (C101)

DGG	OR DG\ (TOP \		CKAGE V)
1 <u>0EBY</u> [1A [1Y [1 2 3	48 47 46] 10EAB] V _{CC}] 1B
GND 2A 2Y V _{CC}	4 5 6 7	44 43] GND] BIAS V _{CC}] 2B] V _{CC}
20EBY [3A1 [GND [LE] 3A2 [8 9 10 11	41 40 39 38	20EAB 3B1 GND V _{CC} 3B2
3A3 [13 14 15 16	36 35 34 33] 3B3] V _{CC}] GND] 3B4
CLKBA [V _{CC} [3A5 [3A6 [GND] 3A7 [17 18 19 20 21 22	30 29 28	CLKAB V _{CC} 3B5 3B6 GND 3B7
3A8 [DIR [23 24	26 25] зв8] v _{cc}

DESCRIPTION/ORDERING INFORMATION

The SN74VMEH22501A 8-bit universal bus transceiver has two integral 1-bit three-wire bus transceivers and is designed for 3.3-V V_{CC} operation with 5-V tolerant inputs. The UBT[™] transceiver allows transparent, latched, and flip-flop modes of data transfer, and the separate LVTTL input and outputs on the bus transceivers provide a feedback path for control and diagnostics monitoring. This device provides a high-speed interface between cards operating at LVTTL logic levels and VME64, VME64x, or VME320⁽¹⁾ backplane topologies.

The SN74VMEH22501A is pin-for-pin capatible to the SN74VMEH22501 (TI literature number SCES357), but operates at a wider operating temperature (-40°C to 85°C) range.

(1) VME320 is a patented backplane construction by Arizona Digital, Inc.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

SCES3620A-DECEMBER 2004-REVISED FEBRUARY 2010



www.ti.com

DESCRIPTION/ORDERING INFORMATION (CONTINUED)

High-speed backplane operation is a direct result of the improved OEC^{TM} circuitry and high drive that has been designed and tested into the VME64x backplane model. The B-port I/Os are optimized for driving large capacitive loads and include pseudo-ETL input thresholds ($\frac{1}{2} V_{CC} \pm 50 \text{ mV}$) for increased noise immunity. These specifications support the 2eVME protocols in VME64x (ANSI/VITA 1.1) and 2eSST protocols in VITA 1.5. With proper design of a 21-slot VME system, a designer can achieve 320-Mbyte transfer rates on linear backplanes and, possibly, 1-Gbyte transfer rates on the VME320 backplane.

All inputs and outputs are 5-V tolerant and are compatible with TTL and 5-V CMOS inputs.

Active bus-hold circuitry holds unused or undriven 3A-port inputs at a valid logic state. Bus-hold circuitry is not provided on 1A or 2A inputs, any B-port input, or any control input. Use of pullup or pulldown resistors with the bus-hold circuitry is not recommended.

This device is fully specified for live-insertion applications using I_{off} , power-up 3-state, and BIAS V_{CC} . The I_{off} circuitry prevents damaging current to backflow through the device when it is powered off/on. The power-up 3-state circuitry places the outputs in the high-impedance state during power up and power down, which prevents driver conflict. The BIAS V_{CC} circuitry precharges and preconditions the B-port input/output connections, preventing disturbance of active data on the backplane during card insertion or removal, and permits true live-insertion capability.

When V_{CC} is between 0 and 1.5 V, the device is in the high-impedance state during power up or power down. However, to ensure the high-impedance state above 1.5 V, output-enable (OE and OEBY) inputs should be tied to V_{CC} through a pullup resistor and output-enable (OEAB) inputs should be tied to GND through a pulldown resistor; the minimum value of the resistor is determined by the drive capability of the device connected to this input.

T _A	PACKAGE ⁽¹⁾		ORDERABLE PART NUMBER	TOP-SIDE MARKING	
–40°C to 85°C	BGA MicroStar™ Junior – ZQL	Tape and reel	SN74VMEH22501AZQLR	VK501A	
	TSSOP – DGG	Tape and reel	SN74VMEH22501ADGGR	VMEH22501A	
	TVSOP – DGV	Tape and reel	SN74VMEH22501ADGVR	VK501A	
	VFBGA – GQL	Tape and reel	SN74VMEH22501AGQLR	VK501A	

(1) Package drawings, thermal data, and symbolization are available at www.ti.com/sc/packaging.

SN74VMEH22501A



www.ti.com

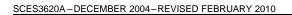
SCES3620A – DECEMBER 2004 – REVISED FEBRUARY 2010

GQL OR ZQL PACKAGE (TOP VIEW) 1 2 3 4 5 6 000000 Α 000000 в С 000000 0 0 0 0 0 0D \bigcirc \bigcirc $\bigcirc \bigcirc$ Е $\bigcirc \bigcirc$ $\bigcirc \bigcirc$ F 0 0 0 0 0 0G 000000 н 000000J 000000 Κ

TERMINAL ASSIGNMENTS⁽¹⁾

	1	2	3	4	5	6
Α	1OEBY	NC	NC	NC	NC	10EAB
В	1Y	1A	GND	GND	V _{CC}	1B
С	2Y	2A	V _{CC}	V _{CC}	BIAS V _{CC}	2B
D	3A1	2OEBY	GND	GND	20EAB	3B1
E	3A2	LE			V _{CC}	3B2
F	3A3	OE			V _{CC}	3B3
G	3A4	CLKBA	GND	GND	CLKAB	3B4
н	3A5	3A6	V _{CC}	V _{CC}	3B6	3B5
J	3A7	3A8	GND GND		3B8	3B7
к	DIR	NC	NC	NC	NC	V _{CC}

(1) NC - No internal connection





FUNCTIONAL DESCRIPTION

The SN74VMEH22501A is a high-drive (–48/64 mA), 8-bit UBT transceiver containing D-type latches and D-type flip-flops for data-path operation in transparent, latched, or flip-flop modes. Data transmission is true logic. The device is uniquely partitioned as 8-bit UBT transceivers with two integrated 1-bit three-wire bus transceivers.

Functional Description for Two 1-Bit Bus Transceivers

The OEAB inputs control the activity of the 1B or 2B port. When OEAB is high, the B-port outputs are active. When OEAB is low, the B-port outputs are disabled.

Separate 1A and 2A inputs and 1Y and 2Y outputs provide a feedback path for control and diagnostics monitoring. The OEBY inputs control the 1Y or 2Y outputs. When OEBY is low, the Y outputs are active. When OEBY is high, the Y outputs are disabled.

The OEBY and OEAB inputs can be tied together to form a simple direction control where an input high yields A data to B bus and an input low yields B data to Y bus.

INP	UTS	OUTPUT	MODE		
OEAB	OEBY	OUTPUT	MODE		
L	Н	Z	Isolation		
Н	Н	A data to B bus	True driver		
L	L	B data to Y bus			
Н	L	A data to B bus, B data to Y bus	True driver with feedback path		

1-BIT BUS TRANSCEIVER FUNCTION TABLE

Functional Description for 8-Bit UBT Transceiver

The 3A and 3B data flow in each direction is controlled by the \overline{OE} and direction-control (DIR) inputs. When \overline{OE} is low, all 3A- or 3B-port outputs are active. When \overline{OE} is high, all 3A- or 3B-port outputs are in the high-impedance state.

	FUNCTION TABLE					
	INPUTS OE DIR		OUTPUT			
			OUTFOI			
	н х		Z			
	L	н	3A data to 3B bus			
	L	L	3B data to 3A bus			

FUNCTION TABLE

The UBT transceiver functions are controlled by latch-enable (LE) and clock (CLKAB and CLKBA) inputs. For 3A-to-3B data flow, the UBT operates in the transparent mode when LE is high. When LE is low, the 3A data is latched if CLKAB is held at a high or low logic level. If LE is low, the 3A data is stored in the latch/flip-flop on the low-to-high transition of CLKAB.

The UBT transceiver data flow for 3B to 3A is similar to that of 3A to 3B, but uses CLKBA.



SCES3620A - DECEMBER 2004 - REVISED FEBRUARY 2010

	INF	PUTS		OUTPUT	MODE		
OE	LE	CLKAB	3A	3B	MODE		
Н	Х	Х	Х	Z	Isolation		
L	L	Н	Х	B ₀ ⁽²⁾	Latched stars as af 24 data		
L	L	L	Х	B ₀ ⁽³⁾	Latched storage of 3A data		
L	Н	Х	L	L	True transportant		
L	н	Х	н	н	True transparent		
L	L	↑	L	L	Clocked storage of 24 date		
L	L	1	Н	Н	Clocked storage of 3A data		

Table 1. UBT TRANSCEIVER FUNCTION TABLE⁽¹⁾

(1) 3A-to-3B data flow is shown; 3B-to-3A data flow is similar, but uses CLKBA.

(2) Output level before the indicated steady-state input conditions were established, provided that CLKAB was high before LE went low

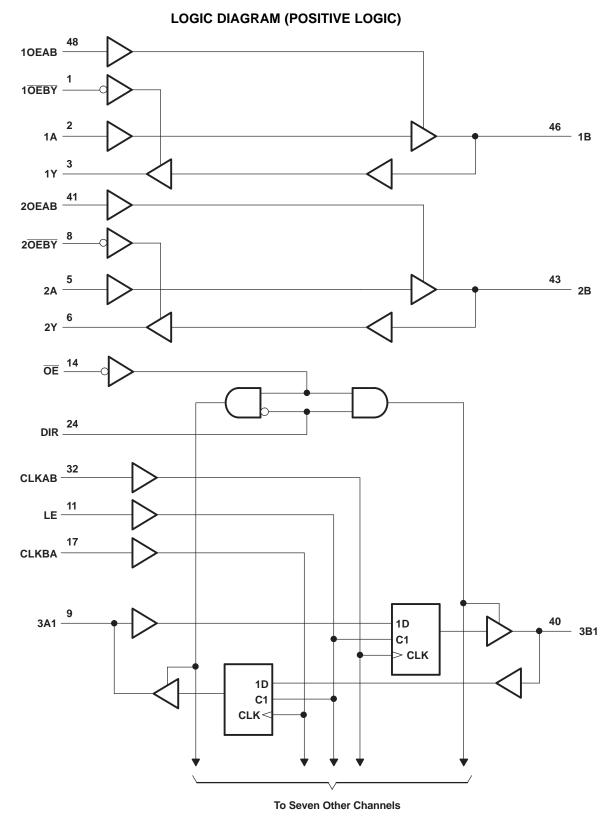
(3) Output level before the indicated steady-state input conditions were established

The UBT transceiver can replace any of the functions shown in Table 2.

Table 2. SN74VMEH22501A UBT Transceiver Replacement Functions

FUNCTION	8 BIT				
Transceiver	'245, '623, '645				
Buffer/driver	'241, '244, '541				
Latched transceiver	'543				
Latch	'373, '573				
Registered transceiver	'646, '652				
Flip-flop '374, '574					
SN74VMEH22501A UBT transce	SN74VMEH22501A UBT transceiver replaces all above functions				





Pin numbers shown are for the DGG and DGV packages.

6



SCES3620A - DECEMBER 2004 - REVISED FEBRUARY 2010

www.ti.com

Absolute Maximum Ratings⁽¹⁾

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT	
V _{CC} , BIAS V _{CC}	Supply voltage range		-0.5	4.6	V	
VI	Input voltage range ⁽²⁾		-0.5	7	V	
Vo	Voltage range applied to any output in the high-impedar	nce or power-off state ⁽²⁾	-0.5	7	V	
	Voltage range applied to any output in the high or low	3A port or Y output	-0.5	V _{CC} + 0.5		
V _O state ⁽²⁾	state ⁽²⁾	B port	-0.5	4.6	V	
	Output current in the low state	3A port or Y output		50	mA	
I _O		B port		100		
		3A port or Y output		-50		
I _O	Output current in the high state	B port		-100	mA	
I _{IK}	Input clamp current	V ₁ < 0		-50	mA	
I _{OK}	Output clamp current	$V_O < 0$ or $V_O > V_{CC}$, B port		-50	mA	
		DGG package		70		
θ_{JA}	Package thermal impedance ⁽³⁾	DGV package	58		°C/W	
		GQL/ZQL package		42		
T _{stg}	Storage temperature range		-65	150	°C	

(1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

(3) The package thermal impedance is calculated in accordance with JESD 51-7.

Recommended Operating Conditions^{(1) (2)}

	1 0		MIN	NOM	MAX	UNIT
V _{CC} , BIAS V _{CC}	Supply voltage		3.15	3.3	3.45	V
VI	Input voltage	Control inputs or A port		V_{CC}	5.5	V
	input voltage	B port		V _{CC}	5.5	v
	Lligh lovel input veltage	Control inputs or A port	2			V
VIH	V _{IH} High-level input voltage	B port	0.5 V _{CC} + 50 mV			V
N/	V _{IL} Low-level input voltage	Control inputs or A port			0.8	V
VIL		B port			0.5 V _{CC} – 50 mV	v
I _{IK}	Input clamp current				–18	mA
	L Park Laws Law for the summer f	3A port and Y output			-12	
I _{OH}	High-level output current	B port			-48	mA
	I and be all a damage an and	3A port and Y output			12	
IOL	Low-level output current	B port			64	mA
Δt/Δv	Input transition rise or fall rate	Outputs enabled			10	ns/V
$\Delta t / \Delta V_{CC}$	Power-up ramp rate		20			μs/V
T _A	Operating free-air temperature		-40		85	°C

 All unused control inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

(2) Proper connection sequence for use of the B-port I/O precharge feature is GND and BIAS V_{CC} = 3.3 V first, I/O second, and V_{CC} = 3.3 V last, because the BIAS V_{CC} precharge circuitry is disabled when any V_{CC} pin is connected. The control inputs can be connected at any time, but normally are connected during the I/O stage. If B-port precharge is not required, any connection sequence is acceptable, but generally, GND is connected first.

SCES3620A-DECEMBER 2004-REVISED FEBRUARY 2010



www.ti.com

Electrical Characteristics

over recommended operating free-air temperature range for A and B ports (unless otherwise noted)

PARAMETER		TEST COND	TIONS	MIN	TYP ⁽¹⁾	MAX	UNIT
V _{IK}		V _{CC} = 3.15 V,	l _l = -18 mA			-1.2	V
	3A port, any B ports, and Y outputs	$V_{CC} = 3.15 \text{ V} \text{ to } 3.45 \text{ V},$	I _{OH} = -100 μA	$V_{CC} - 0.2$			
	3A port and Y outputs	V _{CC} = 3.15 V	I _{OH} = -6 mA	2.4			
V _{OH}		VCC = 5.15 V	I _{OH} = -12 mA	2			V
	Any B port	V _{CC} = 3.15 V	I _{OH} = -24 mA	2.4			
		VCC - 5.15 V	I _{OH} = -48 mA	2			
	3A port, any B ports, and Y outputs	$V_{CC} = 3.15 \text{ V} \text{ to } 3.45 \text{ V},$	I _{OL} = 100 μA			0.2	
	3A port and Y outputs	V _{CC} = 3.15 V	$I_{OL} = 6 \text{ mA}$			0.55	
V _{OL}		V66 = 3.13 V	I _{OL} = 12 mA			0.8	V
Any B port		I _{OL} = 24 mA			0.4		
	V _{CC} = 3.15 V	I _{OL} = 48 mA			0.55		
			I _{OL} = 64 mA			0.6	
	Control inputs,	$V_{CC} = 3.45 V,$	$V_I = V_{CC}$ or GND			±1	
lı	1A and 2A	V _{CC} = 0 or 3.45 V,	V _I = 5.5 V		5		μA
I _{OZH} ⁽²⁾	3A port, any B port, and Y outputs	V _{CC} = 3.45 V,	$V_{O} = V_{CC} \text{ or } 5.5 \text{ V}$			5	μA
. (2)	3A port and Y outputs	N 0.45 M				-5	
I _{OZL} ⁽²⁾	Any B port	– V _{CC} = 3.45 V,	$V_0 = GND$			-20	μA
I _{off}		$V_{CC} = 0$, BIAS $V_{CC} = 0$,	V_{I} or V_{O} = 0 to 5.5 V			±10	μA
I _{BHL} ⁽³⁾	3A port	V _{CC} = 3.15 V,	V _I = 0.8 V	75			μA
I _{BHH} ⁽⁴⁾	3A port	V _{CC} = 3.15 V,	V ₁ = 2 V	-75			μA
I _{BHLO} ⁽⁵⁾	3A port	V _{CC} = 3.45 V,	$V_{I} = 0$ to V_{CC}	500			μA
I _{BHHO} ⁽⁶⁾	3A port	V _{CC} = 3.45 V,	$V_{I} = 0$ to V_{CC}	-500			μA
I _{OZ(PU/PD)}	(7)	$V_{CC} \le 1.5 \text{ V}, V_O = \underline{0.5} \text{ V to } V_{CC}, V_I = \text{GND or } V_{CC}, \overline{\text{OE}} = \text{don't care}$				±10	μA
			Outputs high			30	
I _{CC}		$V_{CC} = 3.45 \text{ V}, I_{O} = 0,$ $V_{I} = V_{CC} \text{ or GND}$	Outputs low			30	mA
			Outputs disabled			30	
I _{CCD}		$V_{CC} = 3.45 \text{ V}, I_{O} = 0,$	Outputs enabled		76		μA/
		V _I = V _{CC} or GND, One data input switching at one-half clock frequency, 50% duty cycle	Outputs disabled		19		clock MHz/ input
ΔI _{CC} ⁽⁸⁾		V_{CC} = 3.15 V to 3.45 V, One input a Other inputs at V_{CC} or GND	at $V_{CC} - 0.6 V$,			750	μA

(1)

All typical values are at V_{CC} = 3.3 V, T_A = 25°C. For I/O ports, the parameters I_{OZH} and I_{OZL} include the input leakage current. (2)

(̀3)́ The bus-hold circuit can sink at least the minimum low sustaining current at VIL max. IBHL should be measured after lowering VIN to GND, then raising it to $V_{\text{IL}}\xspace$ max.

The bus-hold circuit can source at least the minimum high sustaining current at VIH min. IBHH should be measured after raising VIN to (4) V_{CC} , then lowering it to V_{IH} min.

An external driver must source at least I_{BHLO} to switch this node from low to high. An external driver must sink at least I_{BHHO} to switch this node from high to low. High-impedance state during power up or power down (5)

(6)

(7)

(8) This is the increase in supply current for each input that is at the specified TTL voltage level, rather than V_{CC} or GND.



SCES3620A - DECEMBER 2004 - REVISED FEBRUARY 2010

www.ti.com

Electrical Characteristics (continued)

over recommended operating free-air temperature range for A and B ports (unless otherwise noted)

	PARAMETER	Т	EST CONDITIONS	MIN TYP ⁽¹⁾	MAX	UNIT
<u> </u>	1A and 2A inputs	V 245 V at 0		2.8		~ F
Ci	Control inputs	V _I = 3.15 V or 0		2.6		pF
Co	1Y or 2Y outputs	V _O = 3.15 V or 0		5.6		pF
<u>^</u>	3A port	V 22V		7.9		- 5
C _{io}	Any B port	$V_{\rm CC} = 3.3 \rm V,$	V _O = 3.3 V or 0	11	12.5	pF

Live-Insertion Specifications

over recommended operating free-air temperature range for B port

PARAMETER		TEST CONDITIONS			TYP ⁽¹⁾	MAX	UNIT
	V _{CC} = 0 to 3.15 V,	BIAS V_{CC} = 3.15 V to 3.45 V,	$I_{O(DC)} = 0$			5	mA
I_{CC} (BIAS V_{CC})	$V_{CC} = 3.15 \text{ V to } 3.45 \text{ V}^{(2)},$	BIAS V_{CC} = 3.15 V to 3.45 V,	$I_{O(DC)} = 0$			10	μA
Vo	V _{CC} = 0,	BIAS V_{CC} = 3.15 V to 3.45 V		1.3	1.5	1.7	V
	N 0	$V_{O} = 0,$	BIAS V_{CC} = 3.15 V	-20		-100	٨
IO	$V_{CC} = 0$	V _O = 3 V,	BIAS V_{CC} = 3.15 V	20		100	μA

(1) All typical values are at V_{CC} = 3.3 V, T_A = 25°C. (2) V_{CC} - 0.5 V < BIAS V_{CC}

Timing Requirements for UBT Transceiver

over recommended operating conditions (unless otherwise noted) (see Figure 1 and Figure 2)

				MIN	MAX	UNIT
f _{clock}	Clock frequency				120	MHz
	Pulse duration	LE high		2.5		ns
t _w	Fuise duration	CLK high or low		3		115
		3A before CLK↑	Data high	2.1		
		SA DEIDLE CER	Data low	2.2		
		3A before LE↓	CLK high	2		
	Sotup time	SA Delote LE	CLK low	2		ns
t _{su}	Setup time	3B before CLK↑	Data high	2.5		
			Data low	2.7		
		2D before L E	CLK high	2		
		3B before LE↓	CLK low	2		
		24 ofter CLKA	Data high	0		
		3A after CLK↑	Data low	0		
		24 ofter LE	CLK high	1		
	Light time	3A after LE↓	CLK low	1		20
t _h	Hold time	2D offer CLIA	Data high	0		ns
		3B after CLK↑	Data low	0		
		2P offer LE	CLK high	1		
		3B after LE↓	CLK low	1		

SCES3620A - DECEMBER 2004 - REVISED FEBRUARY 2010

TEXAS INSTRUMENTS

www.ti.com

Switching Characteristics for Bus Transceiver Function

over recommended operating conditions (unless otherwise noted) (see Figure 1 and Figure 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	MIN	ТҮР	МАХ	UNIT
t _{PLH}	1A or 2A	1B or 2B	5.1		8.9	20
t _{PHL}		ID UI 2D	4.5		7.8	ns
t _{PLH}	1A or 2A	1\/ or 2\/	7.2		14.5	20
t _{PHL}	TA OLZA	1Y or 2Y	6.1		13	ns
t _{PZH}	OEAB	1P or 2P	4.6		8.1	20
t _{PZL}	OEAB	1B or 2B	3.7		7.4	ns
t _{PHZ}		1B or 2B	3.3		9.7	20
t _{PLZ}	OEAB	ID UI ZD	1.8		4.8	ns
t _r	Transition time,	B port (10%–90%)		4.3		ns
t _f	Transition time,	B port (90%–10%)		4.3		ns
t _{PLH}	1B or 2B	1Y or 2Y	1.6		5.6	20
t _{PHL}		11 01 21	1.6		5.6	ns
t _{PZH}	OEBY	1Y or 2Y	1.2		5.6	20
t _{PZL}	OEBT	IT OF ZY	1.8		4.9	ns
t _{PHZ}	OEBY	1\/ or 2\/	1.4		5.4	20
t _{PLZ}	UEBY	1Y or 2Y	1.7		4.5	ns



SCES3620A - DECEMBER 2004 - REVISED FEBRUARY 2010

Switching Characteristics for UBT Transceiver

over recommended operating conditions (unless otherwise noted) (see Figure 1 and Figure 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	MIN	ΤΥΡ	МАХ	UNIT
f _{max}			120			MHz
t _{PLH}	24	20	5.5		9.3	
t _{PHL}	3A	3B	4.7		8.3	ns
t _{PLH}	LE	3B	6		10.6	20
t _{PHL}	LE	36	4.9		8.7	ns
t _{PLH}	CLKAB	3B	5.8		10.1	200
t _{PHL}	CLKAD	JD	4.6		8.4	ns
t _{PZH}	ŌĒ	3B	4.6		9.3	20
t _{PZL}	UE	30	3.5		8.5	ns
t _{PHZ}	ŌĒ	3B	4.8		9.3 5.7	ns
t _{PLZ}	UL	50	2.4			115
tr	Transition time,	B port (10%–90%)		4.3		ns
t _f	Transition time,	B port (90%–10%)		4.3		ns
t _{PLH}	3B	ЗА	1.7		5.9	ns
t _{PHL}	30	34	1.7		5.9	115
t _{PLH}	LE	ЗА	1.7		5.9	ns
t _{PHL}	LL	34	1.7		5.9	115
t _{PLH}	CLKBA	ЗА	1.4		5.5	200
t _{PHL}	CERBA	34	1.4		5.5	ns
t _{PZH}	ŌĒ	ЗА	1.5		6.2	ns
t _{PZL}	UL	54	2.1		5.5	115
t _{PHZ}	ŌĒ	ЗА	1.8		6.2	200
t _{PLZ}	UE	JA JA	2.3		5.6	ns



Skew Characteristics for Bus Transceiver

for specific worst-case V_{CC} and temperature within the recommended ranges of supply voltage and operating free-air temperature (see Figure 1 and Figure 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	MIN MAX	UNIT
t _{sk(LH)}	1A or 2A	1D or 2D	0.8	
t _{sk(HL)}	TA OI ZA	1B or 2B		ns
t _{sk(LH)}	1P or 2P	1V or 2V	0.7	
t _{sk(HL)}	1B or 2B 1Y or 2Y	0.6	ns	
• (1)	1A or 2A	1B or 2B	1.7	
t _{sk(t)} ⁽¹⁾	1B or 2B	1Y or 2Y	1.2	ns
	1A or 2A	1B or 2B	2.8	
t _{sk(pp)}	1B or 2B	1Y or 2Y	1.4	ns

(1) t_{sk(t)} – Output-to-output skew is defined as the absolute value of the difference between the actual propagation delay for all outputs of the same packaged device. The specifications are given for specific worst-case V_{CC} and temperature and apply to any outputs switching in opposite directions, both low to high (LH) and high to low (HL) [t_{sk(t)}].

Skew Characteristics for UBT

for specific worst-case V_{CC} and temperature within the recommended ranges of supply voltage and operating free-air temperature (see Figure 1 and Figure 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	MIN MAX	UNIT
t _{sk(LH)}	ЗA	3B	1.3	ns
t _{sk(HL)}	34	35	1.1	115
t _{sk(LH)}	CLKAB	3B	0.8	ns
t _{sk(HL)}	CERAB	38	0.8	115
t _{sk(LH)}	3B	3A	0.7	ns
t _{sk(HL)}	30	34	0.6	115
t _{sk(LH)}	CLKBA	3A	0.7	ns
t _{sk(HL)}	CERBA	54	0.6	115
	3A	3B	1.9	
t _{sk(t)} ⁽¹⁾	CLKAB	3В	2.1	ns
^L sk(t)	3B	ЗА	1.2	115
	CLKBA	ЗА	1	
	3A	3B	2.8	
	CLKAB	3B	2.7	20
t _{sk(pp)}	3B	3A	1.3	ns
	CLKBA	3A	1.2	

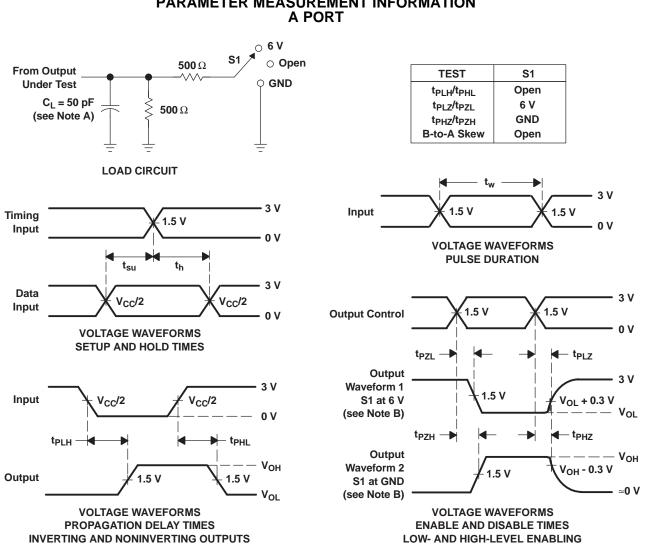
(1) t_{sk(t)} – Output-to-output skew is defined as the absolute value of the difference between the actual propagation delay for all outputs of the same packaged device. The specifications are given for specific worst-case V_{CC} and temperature and apply to any outputs switching in opposite directions, both low to high (LH) and high to low (HL) [t_{sk(t)}].

SN74VMEH22501A



www.ti.com

SCES3620A - DECEMBER 2004-REVISED FEBRUARY 2010



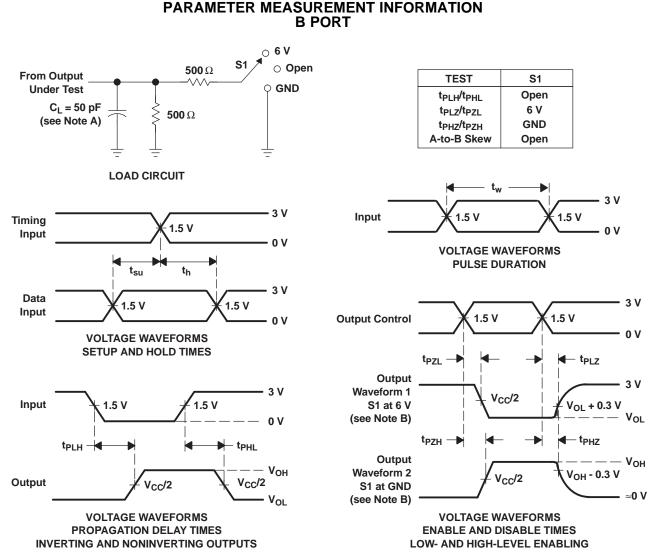
PARAMETER MEASUREMENT INFORMATION

NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \approx 10 MHz, Z_O = 50 Ω , t_r \approx 2 ns, t_f \approx 2 ns.
- D. The outputs are measured one at a time, with one transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms

SCES3620A – DECEMBER 2004 – REVISED FEBRUARY 2010



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \approx 10 MHz, Z_O = 50 Ω, t_r \approx 2 ns, t_f \approx 2 ns.
- D. The outputs are measured one at a time, with one transition per measurement.

Figure 2. Load Circuit and Voltage Waveforms

INSTRUMENTS

EXAS

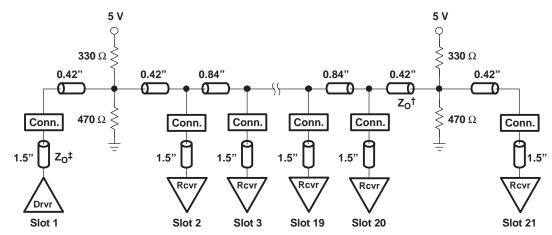
www.ti.com



SCES3620A - DECEMBER 2004 - REVISED FEBRUARY 2010

Distributed-Load Backplane Switching Characteristics

The preceding switching characteristics tables show the switching characteristics of the device into the lumped load shown in the parameter measurement information (PMI) (see Figure 1 and Figure 2). All logic devices currently are tested into this type of load. However, the designer's backplane application probably is a distributed load. For this reason, this device has been designed for optimum performance in the VME64x backplane as shown in Figure 3.



[†] Unloaded backplane trace natural impedence (Z_O) is 45 Ω . 45 Ω to 60 Ω is allowed, with 50 Ω being ideal. [‡] Card stub natural impedence (Z_O) is 60 Ω .

Figure 3. VME64x Backplane

The following switching characteristics tables derived from TI-SPICE models show the switching characteristics of the device into the backplane under full and minimum loading conditions, to help the designer better understand the performance of the VME device in this typical backplane. See www.ti.com/sc/etl for more information.

Driver in Slot 11, With Receiver Cards in All Other Slots (Full Load)

Switching Characteristics for Bus Transceiver Function

over recommended operating conditions (unless otherwise noted) (see Figure 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	MIN	TYP ⁽¹⁾	МАХ	UNIT
t _{PLH}	1A or 2A	1B or 2B	5.9		8.5	20
t _{PHL}		IB OF 2B	5.5		8.7	ns
t _r ⁽²⁾	Transition time, I	Transition time, B port (10%–90%)		8.6	11.4	ns
t _f ⁽²⁾	Transition time, I	B port (90%–10%)	8.9	9	10.8	ns

(1) All typical values are at V_{CC} = 3.3 V, T_A = 25°C. All values are derived from TI-SPICE models.

(2) All t_r and t_f times are taken at the first receiver.

Switching Characteristics for UBT

over recommended operating conditions (unless otherwise noted) (see Figure 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	MIN	TYP ⁽¹⁾	МАХ	UNIT
t _{PLH}	ЗА	3B	6.2		8.9	20
t _{PHL}	ЪA	38	5.6		9	ns
t _{PLH}	LE	3B	6.1		9.1	ns
t _{PHL}	LE	ЗВ	5.6		9	
t _{PLH}	CLKAB	3B	6.2		9.1	20
t _{PHL}	CLKAD	38	5.7		9	ns
t _r ⁽²⁾	Transition time,	, B port (10%–90%)	9	8.6	11.4	ns
t _f ⁽²⁾	Transition time,	, B port (90%–10%)	8.9	9	10.8	ns

All typical values are at V_{CC} = 3.3 V, T_A = 25°C. All values are derived from TI-SPICE models. (1)

(2)All t_r and t_f times are taken at the first receiver.

Skew Characteristics for Bus Transceiver

for specific worst-case V_{CC} and temperature within the recommended ranges of supply voltage and operating free-air temperature (see Figure 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	MIN TYP ⁽¹⁾ MAX	
t _{sk(LH)}	1A or 2A	1B or 2B	2.	
t _{sk(HL)}	TA OF ZA		:	ns 3
t _{sk(t)} ⁽²⁾	1A or 2A	1B or 2B		l ns
t _{sk(pp)}	1A or 2A	1B or 2B	0.5 3.4	l ns

(1)

All typical values are at V_{CC} = 3.3 V, T_A = 25°C. All values are derived from TI-SPICE models. $t_{sk(t)}$ – Output-to-output skew is defined as the absolute value of the difference between the actual propagation delay for all outputs of (2) the same packaged device. The specifications are given for specific worst-case V_{CC} and temperature and apply to any outputs switching in opposite directions, both low to high (LH) and high to low (HL) [t_{sk(t)}].

Skew Characteristics for UBT

for specific worst-case V_{CC} and temperature within the recommended ranges of supply voltage and operating free-air temperature (see Figure 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	MIN TYP ⁽¹⁾ MAX	UNIT
t _{sk(LH)}	24	20	2.4	
t _{sk(HL)}	3A	3B	3.4	ns
t _{sk(LH)}	CLKAR	3B	2.7	
t _{sk(HL)}	CLKAB	ЭВ	3.4	ns
. (2)	3A	3B	1	
$t_{sk(t)}$ (2)	CLKAB			ns
	3A	3B	0.5 3.4	
t _{sk(pp)}	CLKAB	3B	0.6 3.5	ns

All typical values are at V_{CC} = 3.3 V, T_A = 25°C. All values are derived from TI-SPICE models.

tsk(t) - Output-to-output skew is defined as the absolute value of the difference between the actual propagation delay for all outputs of (2)the same packaged device. The specifications are given for specific worst-case V_{CC} and temperature and apply to any outputs switching in opposite directions, both low to high (LH) and high to low (HL) [tsk(t)].

Driver in Slot 1, With One Receiver in Slot 21 (Minimum Load)

Switching Characteristics for Bus Transceiver Function

over recommended operating conditions (unless otherwise noted) (see Figure 3)



SCES3620A - DECEMBER 2004 - REVISED FEBRUARY 2010

Switching Characteristics for Bus Transceiver Function (continued)

over recommended operating conditions (unless otherwise noted) (see Figure 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	MIN	TYP ⁽¹⁾	МАХ	UNIT
t _{PLH}	1A or 2A	1B or 2B	5.5		7.4	20
t _{PHL}	TA OF ZA	TB OF 2B	5.3		7.4	ns
t _r ⁽²⁾	Transition time,	B port (10%–90%)	3.9	3.4	4.4	ns
t _f ⁽²⁾	Transition time,	B port (90%–10%)	3.7	3.4	4.8	ns

All typical values are at V_{CC} = 3.3 V, T_A = 25°C. All values are derived from TI-SPICE models. (1)

All t_r and t_f times are taken at the first receiver. (2)

Switching Characteristics for UBT

over recommended operating conditions (unless otherwise noted) (see Figure 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	MIN	TYP ⁽¹⁾	МАХ	UNIT
t _{PLH}	24	20	5.8		7.9	~~
t _{PHL}	3A	3B	5.5		7.7	ns
t _{PLH}	LE	3B	5.9		8	
t _{PHL}	LE	JD	5.5		7.8	ns
t _{PLH}		20	5.9		8.1	
t _{PHL}	CLKAB	3B	5.5		7.7	ns
t _r ⁽²⁾	Transition time, E	3.9	3.4	4.4	ns	
t _f ⁽²⁾	Transition time, E	3.7	3.4	4.8	ns	

(1) All typical values are at V_{CC} = 3.3 V, T_A = 25°C. All values are derived from TI-SPICE models.

(2) All t_r and t_f times are taken at the first receiver.

Skew Characteristics for Bus Transceiver

for specific worst-case V_{CC} and temperature within the recommended ranges of supply voltage and operating free-air temperature (see Figure 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	MIN TYP ⁽¹⁾ M	
t _{sk(LH)}	1A or 2A	1B or 2B		1.7
t _{sk(HL)}				2.1 ns
t _{sk(t)} ⁽²⁾	1A or 2A	1B or 2B		1 ns
t _{sk(pp)}	1A or 2A	1B or 2B	0.2	2.1 ns

(1)

All typical values are at $V_{CC} = 3.3 \text{ V}$, $T_A = 25^{\circ}$ C. All values are derived from TI-SPICE models. $t_{sk(t)}$ – Output-to-output skew is defined as the absolute value of the difference between the actual propagation delay for all outputs of (2)the same packaged device. The specifications are given for specific worst-case V_{CC} and temperature and apply to any outputs switching in opposite directions, both low to high (LH) and high to low (HL) [$t_{sk(t)}$].

SCES3620A-DECEMBER 2004-REVISED FEBRUARY 2010

Skew Characteristics for UBT

for specific worst-case V_{CC} and temperature within the recommended ranges of supply voltage and operating free-air temperature (see Figure 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	MIN TYP ⁽¹⁾ MAX	UNIT
t _{sk(LH)}	24	20	2	
t _{sk(HL)}	3A	3B	2.3	ns
t _{sk(LH)}		20	2.1	
t _{sk(HL)}	CLKAB	3B	2.4	ns
. (2)	3A	3B	1	
t _{sk(t)} ⁽²⁾	CLKAB	3B	1	ns
	3A	3B	0.2 2.5	
t _{sk(pp)}	CLKAB	3B	0.2 2.9	ns

(1) All typical values are at V_{CC} = 3.3 V, T_A = 25°C. All values are derived from TI-SPICE models.

(2) t_{sk(t)} – Output-to-output skew is defined as the absolute value of the difference between the actual propagation delay for all outputs of the same packaged device. The specifications are given for specific worst-case V_{CC} and temperature and apply to any outputs switching in opposite directions, both low to high (LH) and high to low (HL) [t_{sk(t)}].

By simulating the performance of the device using the VME64x backplane (see Figure 3), the maximum peak current in or out of the B-port output, as the devices switch from one logic state to another, was found to be equivalent to driving the lumped load shown in Figure 4.

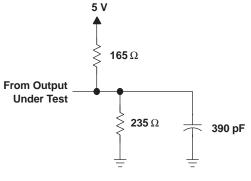




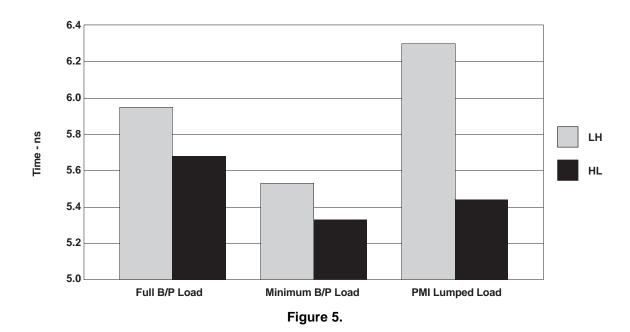
Figure 4. Equivalent AC Peak Output-Current Lumped Load

In general, the rise- and fall-time distribution is shown in Figure 5. Since VME devices were designed for use into distributed loads like the VME64x backplane (B/P), there are significant differences between low-to-high (LH) and high-to-low (HL) values in the lumped load shown in the PMI (see Figure 1 and Figure 2).

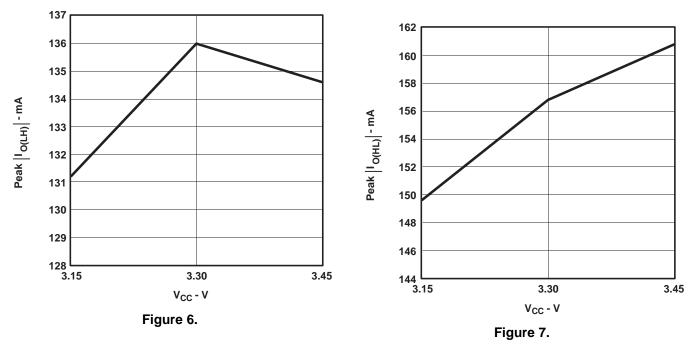
TEXAS INSTRUMENTS

www.ti.com

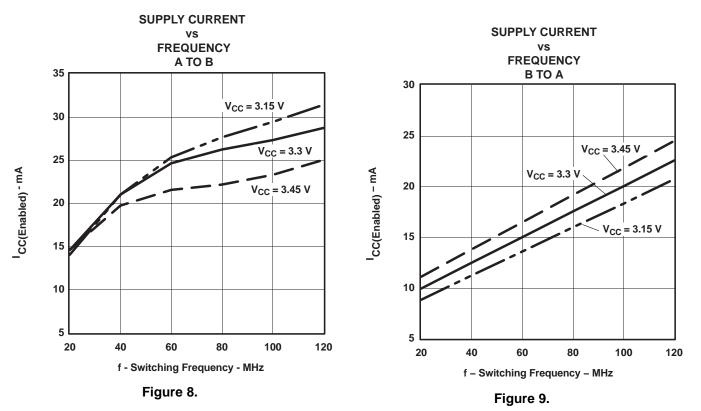
SCES3620A - DECEMBER 2004 - REVISED FEBRUARY 2010



Characterization-laboratory data in Figure 6 and Figure 7 show the absolute ac peak output current, with different supply voltages, as the devices change output logic state. A typical nominal process is shown to demonstrate the devices' peak ac output drive capability.





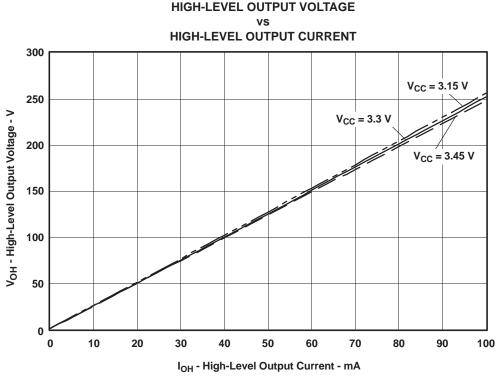


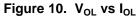
TYPICAL CHARACTERISTICS

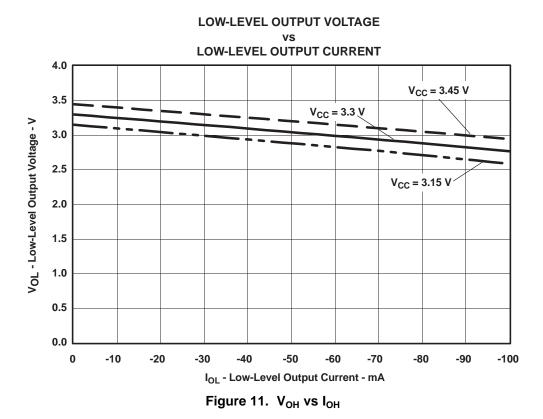


SCES3620A - DECEMBER 2004 - REVISED FEBRUARY 2010

TYPICAL CHARACTERISTICS







SCES3620A – DECEMBER 2004 – REVISED FEBRUARY 2010



www.ti.com

VMEbus Summary

In 1981, the VMEbus was introduced as a backplane bus architecture for industrial and commercial applications. The data-transfer protocols used to define the VMEbus came from the Motorola[™] VERSA bus architecture that owed its heritage to the then recently introduced Motorola 68000 microprocessor. The VMEbus, when introduced, defined two basic data-transfer operations: single-cycle transfers consisting of an address and a data transfer, and a block transfer (BLT) consisting of an address and a sequence of data transfers. These transfers were asynchronous, using a master-slave handshake. The master puts address and data on the bus and waits for an acknowledgment. The selected slave either reads or writes data to or from the bus, then provides a data-acknowledge (DTACK*) signal. The VMEbus system data throughput was 40 Mbyte/s. Previous to the VMEbus, it was not uncommon for the backplane buses to require elaborate calculations to determine loading and drive current for interface design. This approach made designs difficult and caused compatibility problems among manufacturers. To make interface design easier and to ensure compatibility, the developers of the VMEbus architecture defined specific delays based on a 21-slot terminated backplane and mandated the use of certain high-current TTL drivers, receivers, and transceivers.

In 1989, multiplexing block transfer (MBLT) effectively increased the number of bits from 32 to 64, thereby doubling the transfer rate. In 1995, the number of handshake edges was reduced from four to two in the double-edge transfer (2eVME) protocol, doubling the data rate again. In 1997, the VMEbus International Trade Association (VITA) established a task group to specify a synchronous protocol to increase data-transfer rates to 320 Mbyte/s, or more. The unreleased specification, VITA 1.5 [double-edge source synchronous transfer (2eSST)], is based on the asynchronous 2eVME protocol. It does not wait for acknowledgement of the data by the receiver and requires incident-wave switching. Sustained data rates of 1 Gbyte/s, more than ten times faster than traditional VME64 backplanes, are possible by taking advantage of 2eSST and the 21-slot VME320 star-configuration backplane. The VME64x distributed-load backplane. Traditional VME64 backplanes with no changes theoretically can sustain 320 Mbyte/s.

From BLT to 2eSST – A Look at the Evolution of VMEbus Protocols by John Rynearson, Technical Director, VITA, provides additional information on VMEbus and can be obtained at www.vita.com.

DATE	DATE TOPOLOGY	PROTOCOL	DATA BITS	DATA TRANSFERS	PER SYSTEM	FREQUENCY (MHz)			
DATE	TOPOLOGY	PROTOCOL	PER CYCLE	PER CLOCK CYCLE	(Mbyte/s)	BACKPLANE	CLOCK		
1981	VMEbus IEEE-1014	BLT	32	1	40	10	10		
1989	VME64	MBLT	64	1	80	10	10		
1995	VME64x	2eVME	64	2	160	10	20		
1997	VME64x	2eSST	64	2-No Ack	160–320	10–20	20–40		
1999	VME320	2eSST	64	2-No Ack	320-1000	20-62.5	40–125		

Maximum Data Transfer Rates

Applicability

Target applications for VME backplanes include industrial controls, telecommunications, simulation, high-energy physics, office automation, and instrumentation systems.



PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	Eco Plan ⁽²⁾	Lead/ Ball Finish	MSL Peak Temp ⁽³⁾	Samples (Requires Login)
74VMEH22501ADGGRE4	ACTIVE	TSSOP	DGG	48	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
74VMEH22501ADGGRG4	ACTIVE	TSSOP	DGG	48	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
74VMEH22501ADGVRE4	ACTIVE	TVSOP	DGV	48	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
74VMEH22501ADGVRG4	ACTIVE	TVSOP	DGV	48	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
SN74VMEH22501ADGGR	ACTIVE	TSSOP	DGG	48	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
SN74VMEH22501ADGVR	ACTIVE	TVSOP	DGV	48	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	
SN74VMEH22501AGQLR	LIFEBUY	BGA MICROSTAR JUNIOR	GQL	56	1000	TBD	SNPB	Level-1-240C-UNLIM	
SN74VMEH22501AZQLR	ACTIVE	BGA MICROSTAR JUNIOR	ZQL	56	1000	Green (RoHS & no Sb/Br)	SNAGCU	Level-1-260C-UNLIM	

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)



4-May-2012

⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF SN74VMEH22501A :

Enhanced Product: SN74VMEH22501A-EP

NOTE: Qualified Version Definitions:

• Enhanced Product - Supports Defense, Aerospace and Medical Applications

PACKAGE MATERIALS INFORMATION

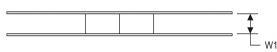
www.ti.com

TAPE AND REEL INFORMATION

REEL DIMENSIONS

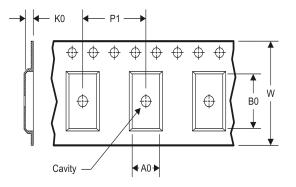
Texas Instruments





TAPE AND REEL INFORMATION

TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

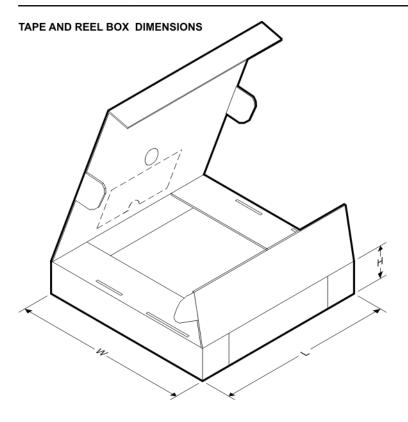
*All dimensions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74VMEH22501ADGGR	TSSOP	DGG	48	2000	330.0	24.4	8.6	15.8	1.8	12.0	24.0	Q1
SN74VMEH22501ADGVR	TVSOP	DGV	48	2000	330.0	16.4	7.1	10.2	1.6	12.0	16.0	Q1
SN74VMEH22501AGQLR	BGA MI CROSTA R JUNI OR	GQL	56	1000	330.0	16.4	4.8	7.3	1.45	8.0	16.0	Q1
SN74VMEH22501AZQLR	BGA MI CROSTA R JUNI OR	ZQL	56	1000	330.0	16.4	4.8	7.3	1.5	8.0	16.0	Q1

TEXAS INSTRUMENTS

www.ti.com

PACKAGE MATERIALS INFORMATION

23-Jul-2012

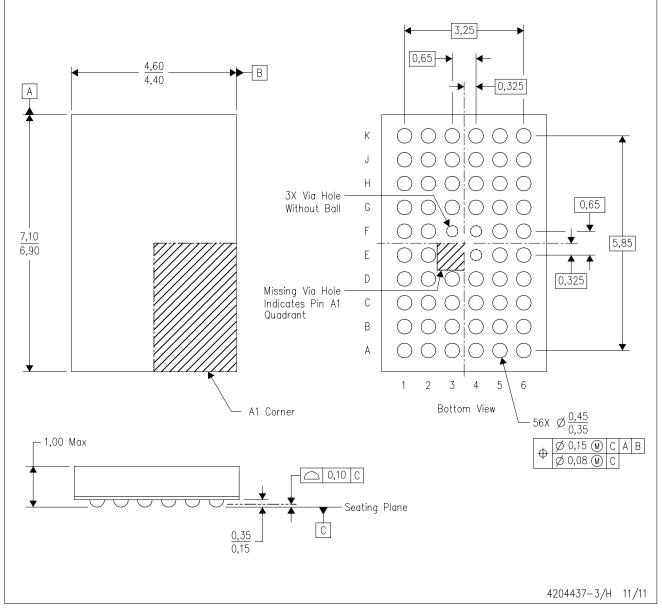


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74VMEH22501ADGGR	TSSOP	DGG	48	2000	367.0	367.0	45.0
SN74VMEH22501ADGVR	TVSOP	DGV	48	2000	367.0	367.0	38.0
SN74VMEH22501AGQLR	BGA MICROSTAR JUNIOR	GQL	56	1000	333.2	345.9	28.6
SN74VMEH22501AZQLR	BGA MICROSTAR JUNIOR	ZQL	56	1000	333.2	345.9	28.6

ZQL (R-PBGA-N56)

PLASTIC BALL GRID ARRAY



NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. Falls within JEDEC MO-285 variation BA-2.
- D. This package is Pb-free. Refer to the 56 GQL package (drawing 4200583) for tin-lead (SnPb).

MicroStar Junior is a trademark of Texas Instruments



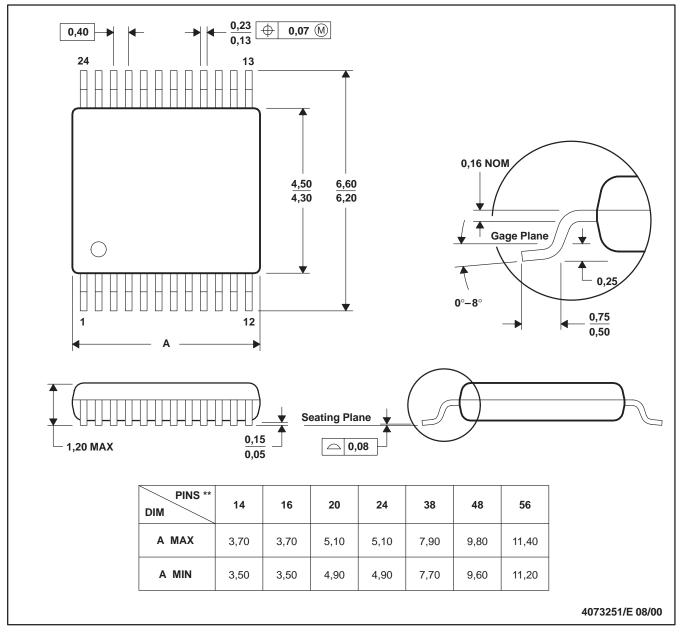
MECHANICAL DATA

PLASTIC SMALL-OUTLINE

MPDS006C - FEBRUARY 1996 - REVISED AUGUST 2000

DGV (R-PDSO-G**)

24 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

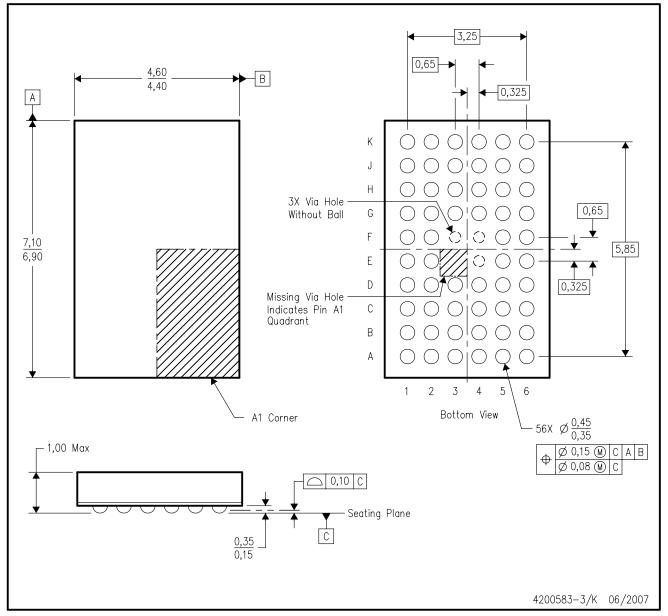
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15 per side.
- D. Falls within JEDEC: 24/48 Pins MO-153

14/16/20/56 Pins – MO-194



GQL (R-PBGA-N56)

PLASTIC BALL GRID ARRAY



NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. Falls within JEDEC MO-285 variation BA-2.
- D. This package is tin-lead (SnPb). Refer to the 56 ZQL package (drawing 4204437) for lead-free.



MECHANICAL DATA

MTSS003D - JANUARY 1995 - REVISED JANUARY 1998

DGG (R-PDSO-G**)

PLASTIC SMALL-OUTLINE PACKAGE

48 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold protrusion not to exceed 0,15.
- D. Falls within JEDEC MO-153



IMPORTANT NOTICE

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, enhancements, improvements and other changes to its semiconductor products and services per JESD46C and to discontinue any product or service per JESD48B. Buyers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All semiconductor products (also referred to herein as "components") are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its components to the specifications applicable at the time of sale, in accordance with the warranty in TI's terms and conditions of sale of semiconductor products. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by applicable law, testing of all parameters of each component is not necessarily performed.

TI assumes no liability for applications assistance or the design of Buyers' products. Buyers are responsible for their products and applications using TI components. To minimize the risks associated with Buyers' products and applications, Buyers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right relating to any combination, machine, or process in which TI components or services are used. Information published by TI regarding third-party products or services does not constitute a license to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of significant portions of TI information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. TI is not responsible or liable for such altered documentation. Information of third parties may be subject to additional restrictions.

Resale of TI components or services with statements different from or beyond the parameters stated by TI for that component or service voids all express and any implied warranties for the associated TI component or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

Buyer acknowledges and agrees that it is solely responsible for compliance with all legal, regulatory and safety-related requirements concerning its products, and any use of TI components in its applications, notwithstanding any applications-related information or support that may be provided by TI. Buyer represents and agrees that it has all the necessary expertise to create and implement safeguards which anticipate dangerous consequences of failures, monitor failures and their consequences, lessen the likelihood of failures that might cause harm and take appropriate remedial actions. Buyer will fully indemnify TI and its representatives against any damages arising out of the use of any TI components in safety-critical applications.

In some cases, TI components may be promoted specifically to facilitate safety-related applications. With such components, TI's goal is to help enable customers to design and create their own end-product solutions that meet applicable functional safety standards and requirements. Nonetheless, such components are subject to these terms.

No TI components are authorized for use in FDA Class III (or similar life-critical medical equipment) unless authorized officers of the parties have executed a special agreement specifically governing such use.

Only those TI components which TI has specifically designated as military grade or "enhanced plastic" are designed and intended for use in military/aerospace applications or environments. Buyer acknowledges and agrees that any military or aerospace use of TI components which have *not* been so designated is solely at the Buyer's risk, and that Buyer is solely responsible for compliance with all legal and regulatory requirements in connection with such use.

TI has specifically designated certain components which meet ISO/TS16949 requirements, mainly for automotive use. Components which have not been so designated are neither designed nor intended for automotive use; and TI will not be responsible for any failure of such components to meet such requirements.

Products		Applications	
Audio	www.ti.com/audio	Automotive and Transportation	www.ti.com/automotive
Amplifiers	amplifier.ti.com	Communications and Telecom	www.ti.com/communications
Data Converters	dataconverter.ti.com	Computers and Peripherals	www.ti.com/computers
DLP® Products	www.dlp.com	Consumer Electronics	www.ti.com/consumer-apps
DSP	dsp.ti.com	Energy and Lighting	www.ti.com/energy
Clocks and Timers	www.ti.com/clocks	Industrial	www.ti.com/industrial
Interface	interface.ti.com	Medical	www.ti.com/medical
Logic	logic.ti.com	Security	www.ti.com/security
Power Mgmt	power.ti.com	Space, Avionics and Defense	www.ti.com/space-avionics-defense
Microcontrollers	microcontroller.ti.com	Video and Imaging	www.ti.com/video
RFID	www.ti-rfid.com		
OMAP Mobile Processors	www.ti.com/omap	TI E2E Community	e2e.ti.com
Wireless Connectivity	www.ti.com/wirelessconnectivity		

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2012, Texas Instruments Incorporated